

03500.017668.

PATENT APPLICATION

ZPW

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of:)
AKIRA HAYAMA) : Examiner: N.Y.A.
Application No.: 10/693,872) : Group Art Unit: N.Y.A.
Filed: October 28, 2003) :
For: METHOD OF MANUFACTURING)
AN ENVELOPE AND METHOD :
OF MANUFACTURING AN)
ELECTRON BEAM APPARATUS : September 9, 2005

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

SECOND INFORMATION DISCLOSURE STATEMENT

Sir:

In compliance with the duty of disclosure under 37 C.F.R. § 1.56 and in accordance with the practice under 37 C.F.R. §§ 1.97 and 1.98, the Examiner's attention is directed to the documents listed on the enclosed Form PTO-1449. Copies of the documents listed, and a copy of the Korean office action citing these documents and its Japanese translation are enclosed.

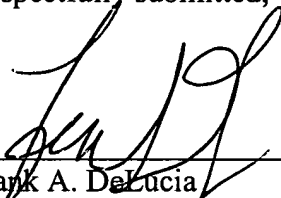
For the concise statement of relevance of non-English document 2000-133172, the Examiner is respectfully referred to the English abstract attached thereto.

Also, for the concise statement of relevance of non-English document 2000-323073, the Examiner is respectfully referred to the English abstract attached thereto.

It is respectfully requested that the above information be considered by the Examiner and that a copy of the enclosed Form PTO-1449 be returned indicating that such information has been considered.

Applicant's undersigned attorney may be reached in our New York office by telephone at (212) 218-2100. All correspondence should continue to be directed to our address given below.

Respectfully submitted,



Frank A. DeLucia
Attorney for Applicant
Registration No. 42,476

FITZPATRICK, CELLA, HARPER & SCINTO
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NY_MAIN 523291v1

FORM PTO 1449 (modified)

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

03500.017668.

APPLICATION NO.

10/693,872

APPLICANT

ARIKA HAYAMA

FILING DATE

October 28, 2003

GROUP

NYALIST OF REFERENCES CITED BY APPLICANT(S)
(Use several sheets if necessary)

U.S. PATENT DOCUMENTS

| INITIAL | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE IF APPROPRIATE |
|---------|--------------------|------|------|-------|----------|-------------------------------|
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FOREIGN PATENT DOCUMENTS

| DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUBCLASS | TRANSLATION YES/NO/ OR ABSTRACT |
|--------------------|-----------------|--------------|-------|----------|---------------------------------------|
| 2000-133172 | 05/12/00 | JAPAN | | | Abstract |
| 2000-323073 | 11/24/00 | JAPAN | | | Abstract |
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OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)

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EXAMINER

DATE CONSIDERED

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Sheet 1 of 1